## Application/Control No. Applicant(s)/Patent Under Reexamination 10/809,995 NAM ET AL. Notice of References Cited Examiner **Art Unit** Page 1 of 1 Toan Ton 2871 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 349/114 08-2005 Jang et al. US-6,927,820 Α US-6,879,361 04-2005 Moon et al. 349/114 В 11-2004 Sekiguchi, Kanetaka 349/106 С US-6,819,374 US-6,853,421 02-2005 Sakamoto et al. 349/114 D 386/46 Е US-6,795,637 09-2004 Moon et al. Wei et al. 349/114 12-2004 F US-6,831,718 349/113 04-2005 Matsushita et al. US-6,885,418 G US-Н US-1 J US-Κ US-US-US-М **FOREIGN PATENT DOCUMENTS** Date **Document Number** Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U Х

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.